N-Channel Power MOSFET 600 V, 4.8 Ω

Features

- Low ON Resistance
- Low Gate Charge
- ESD Diode–Protected Gate
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant



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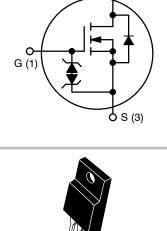
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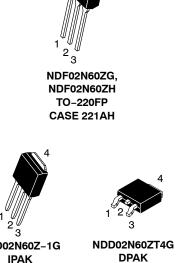
V _{DSS}	R _{DS(on)} (MAX) @ 1 A		
600 V	4.8 Ω		

N-Channel D (2)

Rating	Symbol	NDF	NDD	Unit
Drain-to-Source Voltage	V _{DSS}	600		V
Continuous Drain Current $R_{\theta JC}$ (Note 1)	۱ _D	2.4	2.2	A
Continuous Drain Current $R_{\theta JC}$ T _A = 100°C (Note 1)	۱ _D	1.6	1.4	A
Pulsed Drain Current, V _{GS} @ 10 V	I _{DM}	10	9	Α
Power Dissipation $R_{\theta JC}$	PD	24	57	W
Gate-to-Source Voltage	V _{GS}	±3	0	V
Single Pulse Avalanche Energy, $I_D = 2.4 A$	E _{AS}	120		mJ
ESD (HBM) (JESD 22–A114)	V _{esd}	2500		V
RMS Isolation Voltage (t = 0.3 sec., R.H. \leq 30%, T _A = 25°C) (Figure 17)	V _{ISO}	4500		V
Peak Diode Recovery (Note 2)	dv/dt	4.5		V/ns
Continuous Source Current (Body Diode)	I _S	2.4		A
Maximum Temperature for Soldering Leads	ΤL	260		°C
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 150		°C

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)





NDD02N60Z-1G IPAK CASE 369D

CASE 369AA

ORDERING AND MARKING INFORMATION

See detailed ordering, marking and shipping information on page 7 of this data sheet.

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assumed, damage may occur and reliability may be affected.

2. $I_{SD} = 2.4$ Å, di/dt ≤ 100 Å/ μ s, $V_{DD} \leq BV_{DSS}$, $T_J = +150^{\circ}C$

1. Limited by maximum junction temperature

THERMAL RESISTANCE

Parameter			Value	Unit
Junction-to-Case (Drain)	NDF02N60Z NDD02N60Z	$R_{\theta JC}$	4.9 2.2	°C/W
Junction-to-Ambient Steady State	(Note 3) NDF02N60Z (Note 4) NDD02N60Z (Note 3) NDD02N60Z-1	$R_{ heta JA}$	51 41 80	

3. Insertion mounted

4. Surface mounted on FR4 board using 1" sq. pad size, (Cu area = 1.127 in sq [2 oz] including traces).

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 1 mA		BV _{DSS}	600			V
Breakdown Voltage Temperature Coeffi- cient	Reference to 25°C I _D = 1 mA	Э,	$\Delta BV_{DSS}/\Delta T_{J}$		0.6		V/°C
Drain-to-Source Leakage Current	<u> </u>	25°C	I _{DSS}			1	μΑ
	$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$	150°C				50	
Gate-to-Source Forward Leakage	V _{GS} = ±20 V		I _{GSS}			±10	μΑ
ON CHARACTERISTICS (Note 5)							
Static Drain-to-Source On-Resistance	V _{GS} = 10 V, I _D = 1.0	A (R _{DS(on)}		4.0	4.8	Ω
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 50$	μA	V _{GS(th)}	3.0	4.0	4.5	V
Forward Transconductance	V _{DS} = 15 V, I _D = 1.2 A		g fs		1.7		S
DYNAMIC CHARACTERISTICS							
Input Capacitance (Note 6)	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		C _{iss}	215	274	325	pF
Output Capacitance (Note 6)			C _{oss}	25	34	45	
Reverse Transfer Capacitance (Note 6)			C _{rss}	4.0	7.0	10	
Total Gate Charge (Note 6)			Qg	5.0	10	16	nC
Gate-to-Source Charge (Note 6)	V _{DD} = 300 V, I _D = 2.	4 A,	Q _{gs}	1.5	2.4	4.0	1
Gate-to-Drain ("Miller") Charge (Note 6)	V _{GS} = 10 V		Q _{gd}	3.5	5.3	8.0	
Plateau Voltage			V _{GP}		6.4		V
Gate Resistance			R _g		4.9		Ω
RESISTIVE SWITCHING CHARACTERIST	ICS					•	
Turn-On Delay Time			t _{d(on)}		9.0		ns
Rise Time	V_{DD} = 300 V, I_D = 2.4 A, V_{GS} = 10 V, R_G = 5 Ω		t _r		7.0		
Turn-Off Delay Time			t _{d(off)}		15		
Fall Time			t _f		7.0		
SOURCE-DRAIN DIODE CHARACTERIS	FICS (T _C = 25°C unless other	erwise not	ed)				
Diode Forward Voltage	I _S = 2.4 A, V _{GS} = 0		V _{SD}			1.6	V

 V_{GS} = 0 V, V_{DD} = 30 V I_S = 2.4 A, di/dt = 100 A/ μs Q_{rr} Reverse Recovery Charge 0.7 μC Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product

t_{rr}

240

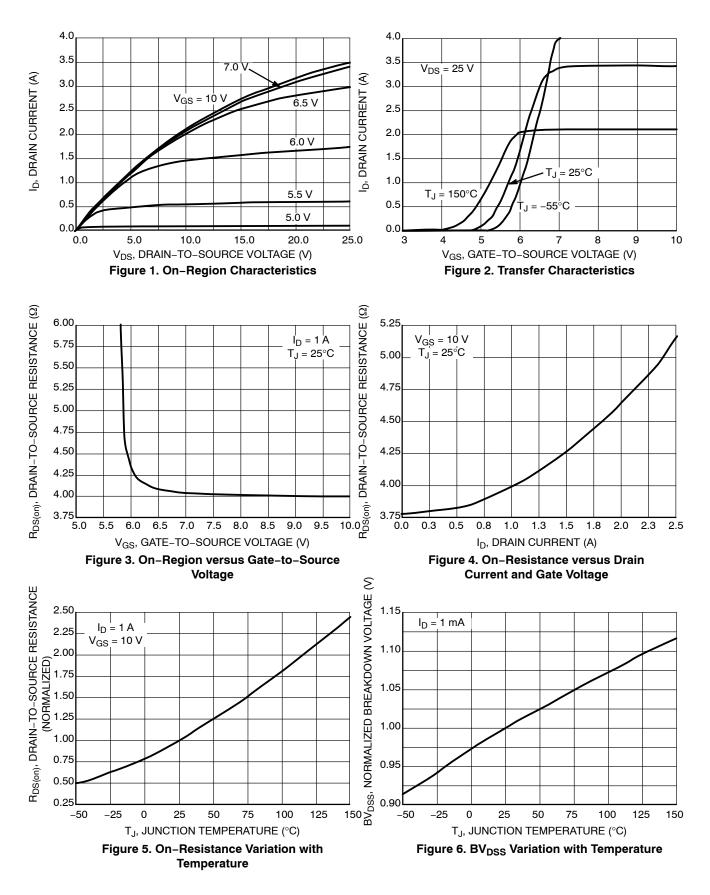
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performance may not be indicated by the Electrical Characteristics if operated under different conditions.

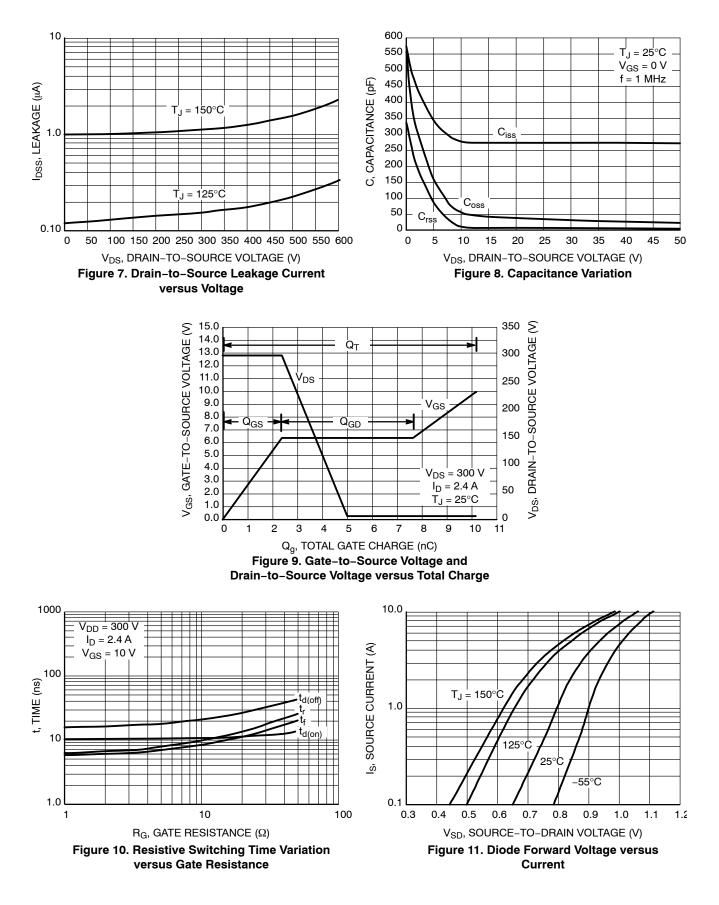
5. Pulse Width \leq 380 µs, Duty Cycle \leq 2%. 6. Guaranteed by design.

Reverse Recovery Time

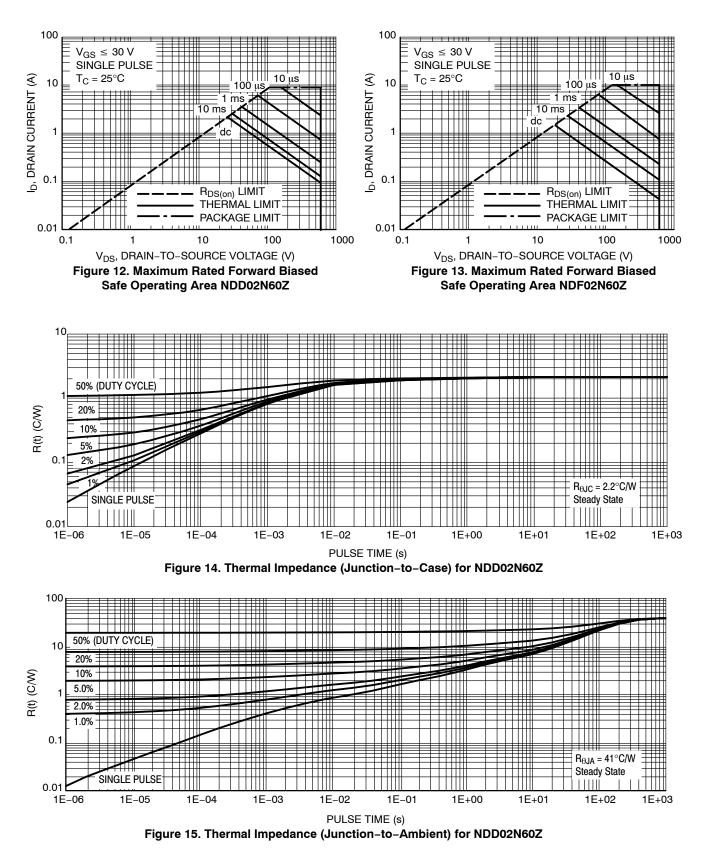
TYPICAL CHARACTERISTICS

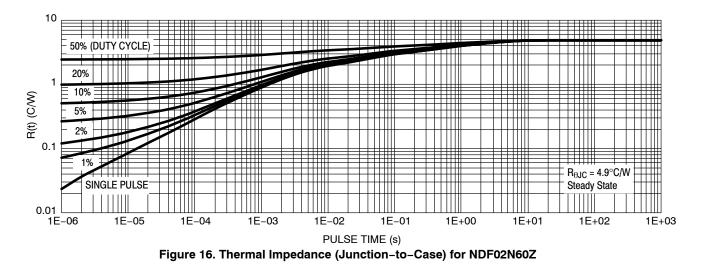


TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS





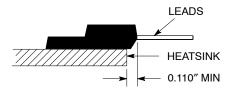


Figure 17. Isolation Test Diagram

Measurement made between leads and heatsink with all leads shorted together.

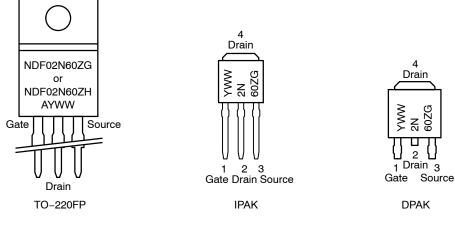
*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NDF02N60ZG	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail
NDF02N60ZH	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail
NDD02N60Z-1G	IPAK (Pb-Free, Halogen-Free)	75 Units / Rail
NDD02N60ZT4G	DPAK (Pb-Free, Halogen-Free)	2500 / Tape and Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MARKING DIAGRAMS



- A = Location Code
- Y = Year
- WW = Work Week
- G, H = Pb-Free, Halogen-Free Package

PACKAGE DIMENSIONS

TO-220 FULLPACK, 3-LEAD CASE 221AH

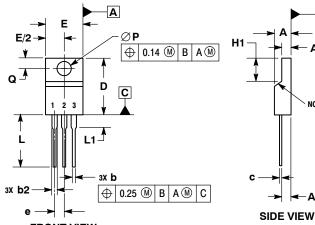
ISSUE F

A1

NOTE 3

A2

B SEATING PLANE

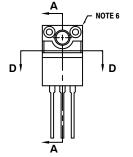


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS. 3. CONTOUR UNCONTROLLED IN THIS AREA. 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH AND GATE PROTRUSIONS. MOLD FLASH AND GATE PROTRUSIONS NOT TO EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE TO BE MEASURED AT OUTERMOST EXTREME OF THE PLASTIC BODY. 5. DIMENSION D2 DOES NOT INCLUDE DAMBAR PROTRUSION. LEAD WIDTH INCLUDING PROTRUSION SHALL NOT EXCEED 2.00. 6. CONTOURS AND FEATURES OF THE MOLEDE PACKAGE BODY MAY VARY WITHIN THE ENVELOP DEFINED BY DIMENSIONS A1 AND H1 FOR MANUFACTURING PURPOSES.

	MILLIMETERS					
DIM	MIN					
Α	4.30	4.70				
A1	2.50	2.90				
A2	2.50	2.90				
b	0.54	0.84				
b2	1.10	1.40				
C	0.49	0.79				
D	14.70	15.30				
Е	9.70	10.30				
е	2.54	2.54 BSC				
H1	6.60	7.10				
L	12.50	14.73				
L1		2.80				
Р	3.00	3.40				
Q	2.80	3.20				

FRONT VIEW



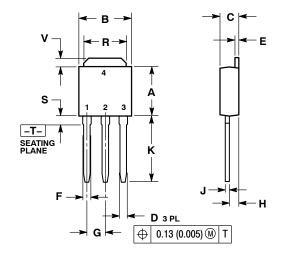


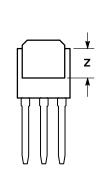
NOTE 6 **SECTION A-A**

ALTERNATE CONSTRUCTION

PACKAGE DIMENSIONS

IPAK CASE 369D ISSUE C





NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. INCHES MILLIMETERS DIM MIN MAX MIN MAX

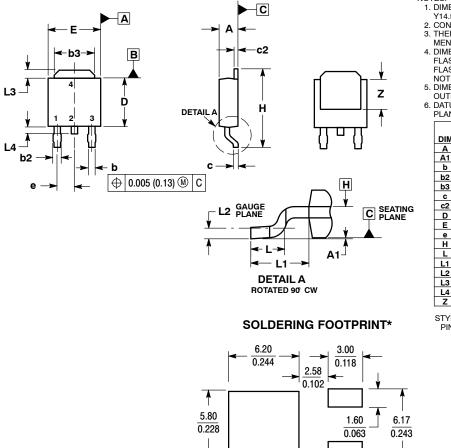
	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	BSC	2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
Κ	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
V	0.035	0.050	0.89	1.27	
Ζ	0.155		3.93		

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

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PACKAGE DIMENSIONS

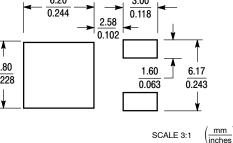
DPAK (SINGLE GAUGE) CASE 369AA **ISSUE B**



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- FLASH, PROTRUSIONS, OR BURRS, MOLD FLASH, PROTRUSIONS, OR BURRS, MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- NOT EXCEED 0.006 INCHES PER SIDE. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	BSC 2.29 B	
н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74 REF	
L2	0.020	BSC	0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	



STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE

DRAIN

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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